

Notice of References Cited		Application/Control No. 10/722,838	Applicant(s)/Patent Under Reexamination BOON, SUAN JEUNG	
		Examiner James M. Mitchell	Art Unit 2813	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0109228	08-2002	Buchwalter et al.	257/738
*	B	US-6,495,916	12-2002	Ohuchi et al.	257/737
*	C	US-6,441,487	08-2002	Elenius et al.	257/738
*	D	US-6,187,615	02-2001	Kim et al.	438/113
*	E	US-2005/0173809	08-2005	Yamamoto et al.	257/780
*	F	US-6,528,349	03-2003	Patel et al.	438/117
*	G	US-6,707,100	03-2004	Gajda, Mark A.	257/330
*	H	US-5,929,482	07-1999	Kawakami et al.	257/328
*	I	US-6,049,124	04-2000	Raiser et al.	257/712
*	J	US-6,313,522	11-2001	Akram et al.	257/686
*	K	US-6,159,837	12-2000	Yamaji et al.	438/613
*	L	US-6,181,010	01-2001	Nozawa, Kazuhiko	257/737
*	M	US-2002/0022301	02-2002	Kwon et al.	438/113

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.